Search Notes					

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/974,656	LEE ET AL.	
Examiner	Art Unit	
Nauven Nao	2663	

	SEARCHED					
Class	Subclass	Date	Examiner			
370	335	2/16/2006	NHN			
370	342	2/16/2006	NHN			
370	208	2/16/2006	NHN			
370	209	2/16/2006	NHN			
714	786	2/16/2006	NHN			
714	790	2/16/2006	NHN			
370	252	2/16/2006	NHN			

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
370	342	2/16/2006	NHN		
370	335	2/16/2006	NHN		
714	790	2/16/2006	NHN		
714/786		2/16/2006	NHN		

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DATE	EXMR
2/16/2006	NHN
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